

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/635,744	NEMAWARKAR ET AL.
	Examiner	Art Unit
	Phuoc H. Nguyen	2143

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,192,452	02-2001	Bannister et al.	711/141
*	C	US-6,779,036	08-2004	Deshpande, Sanjay Raghunath	709/232
*	D	US-6,081,874	06-2000	Carpenter et al.	711/141
*	E	US-2003/0088754	05-2003	Barry et al.	712/11
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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